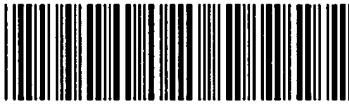


Search Notes

Application/Control No.

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Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

KOBAYASHI, KEVIN W.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	261	9/10/2004	NKV
330	267	9/10/2004	NKV
330	285	9/10/2004	NKV
330	288	9/10/2004	NKV
330	292	9/10/2004	NKV
330	296	9/10/2004	NKV
330	310	9/10/2004	NKV
330	311	9/10/2004	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
CLASSES	ABOVE	3/18/2005	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	3/18/2005	NKV